

Notice of References Cited

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Application/Control No.	Applicant(s)/Pater	nt Under
09/437,764	Reexamination YUN ET AL.	
Examiner	Art-Unit	
Steven HD Nauven	2665	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,075,989	06-2000	Moore et al.	455/436
	В	US-6,122,266	09-2000	Lynch, Michael A.	370/335
	С	US-6,556,551	04-2003	Schwartz, Adam L.	370/331
	D	US-6,272,122	08-2001	Wee, Pyeong-Hwan	370/342
	Е	US-			
	F	US-			
	G	US-			
	н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	х				

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) ates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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